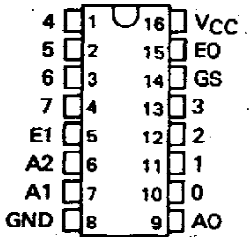
SDLS161

SN54LS348, SN74LS348 (TIM9908)
8-LINE TO 3-LINE PRIORITY ENCODERS WITH 3-STATE OUTPUTS

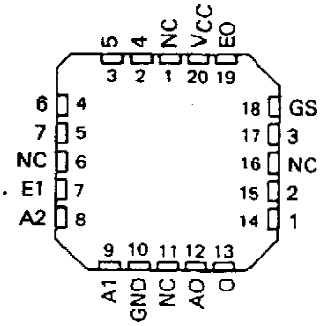
OCTOBER 1976 — REVISED MARCH 1988

- 3-State Outputs Drive Bus Lines Directly
- Encodes 8 Data Lines to 3-Line Binary (Octal)
- Applications Include:
  - N-Bit Encoding
  - Code Converters and Generators
- Typical Data Delay . . . 15 ns
- Typical Power Dissipation . . . 60 mW

SN54LS348 . . . J OR W PACKAGE
SN74LS348 . . . D OR N PACKAGE
(TOP VIEW)



SN54LS348 . . . FK PACKAGE
(TOP VIEW)



NC — No internal connection

description

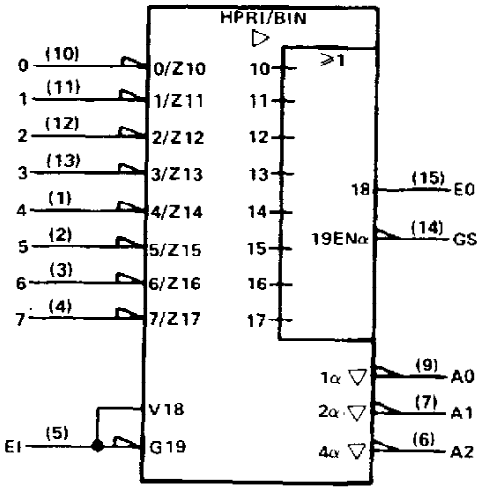
These TTL encoders feature priority decoding of the inputs to ensure that only the highest-order data line is encoded. The 'LS348 circuits encode eight data lines to three-line (4-2-1) binary (octal). Cascading circuitry (enable input E1 and enable output EO) has been provided to allow octal expansion. Outputs A0, A1, and A2 are implemented in three-state logic for easy expansion up to 64 lines without the need for external circuitry. See Typical Application Data.

FUNCTION TABLE

INPUTS								OUTPUTS				
EI	0	1	2	3	4	5	6	7	A2	A1	A0	GS	EO
H	X	X	X	X	X	X	X	X	Z	Z	Z	H	H
L	H	H	H	H	H	H	H	H	Z	Z	Z	H	L
L	X	X	X	X	X	X	X	L	L	L	L	L	H
L	X	X	X	X	X	X	L	H	L	L	H	L	H
L	X	X	X	X	X	L	H	H	L	H	L	L	H
L	X	X	X	X	L	H	H	H	L	H	H	L	H
L	X	X	X	L	H	H	H	H	H	L	L	L	H
L	X	X	L	H	H	H	H	H	H	L	H	L	H
L	X	L	H	H	H	H	H	H	H	H	L	L	H
L	L	H	H	H	H	H	H	H	H	H	H	L	H

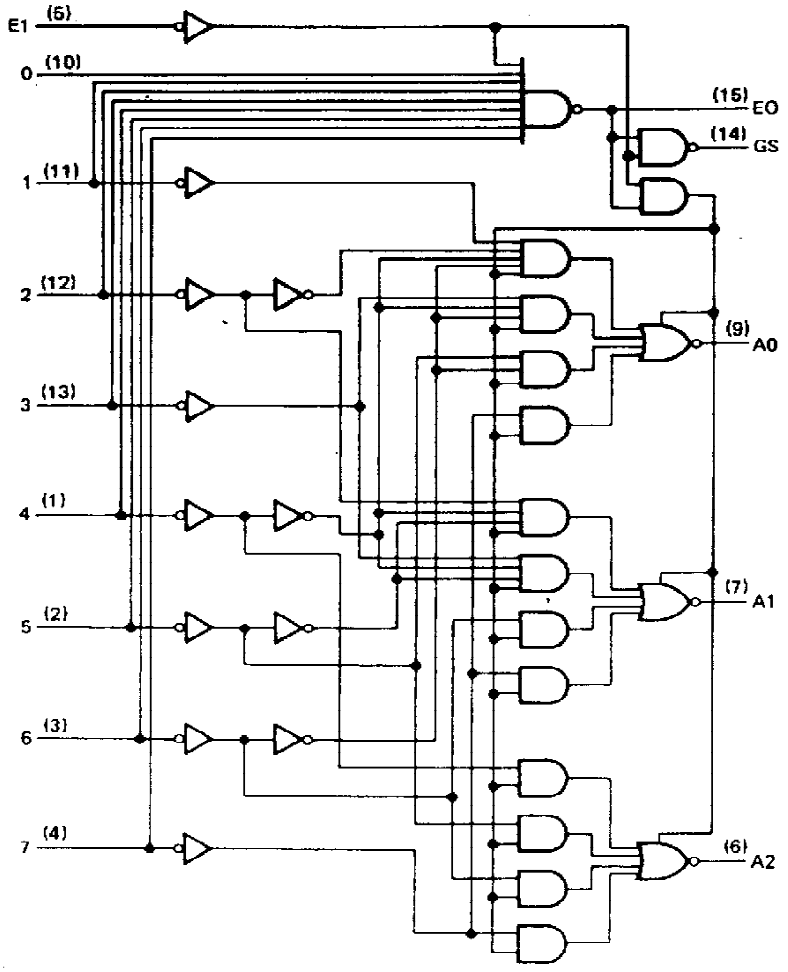
H = high logic level, L = low logic level, X = irrelevant
Z = high-impedance state

logic symbol†



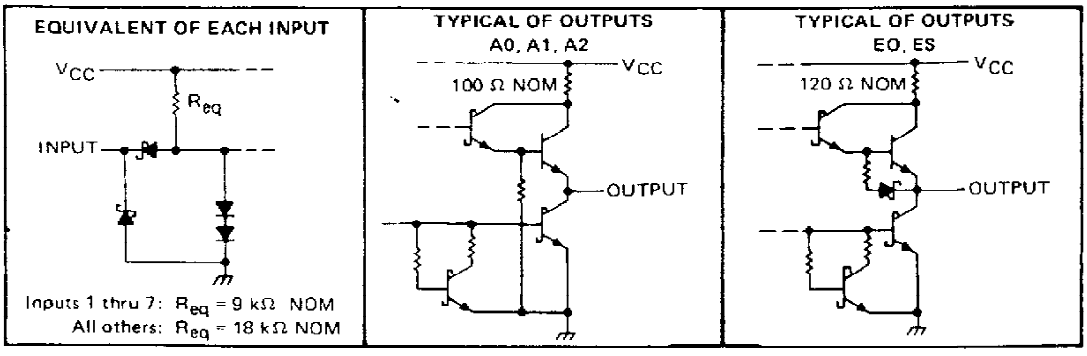
† This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.
Pin numbers shown are for D, J, N, and W packages.

logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

schematic of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54LS348 . . . . . −55°C to 125°C
SN74LS348 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54LS348			SN74LS348			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}		4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}	A0, A1, A2			−1			−2.6	mA
	EO, GS			−400			−400	μA
Low-level output current, I_{OL}	A0, A1, A2			12			24	mA
	EO, GS			4			8	mA
Operating free-air temperature, T_A		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†		SN54LS348			SN74LS348			UNIT
					MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH}	High-level input voltage				2			2			V
V_{IL}	Low-level input voltage						0.7			0.8	V
V_{IK}	Input clamp voltage		V_{CC} = MIN,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}	High-level output voltage	A0, A1, A2	V_{CC} = MIN, V_{IH} = 2 V,	I_{OH} = −1 mA	2.4	3.1					V
				I_{OH} = −2.6 mA				2.4	3.1		
		EO, GS	V_{IL} = V_{IL}max	I_{OH} = −400 μA	2.5	3.4		2.7	3.4		
V_{OL}	Low-level Output voltage	A0, A1, A2	V_{CC} = MIN, V_{IH} = 2 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
				I_{OL} = 24 mA					0.35	0.5	
		EO, GS	V_{IL} = V_{IL}max	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	
				I_{OL} = 8 mA					0.35	0.5	
I_{OZ}	Off-State (high-impedance state) output current	A0, A1, A2	V_{CC} = MAX, V_{IH} = 2 V	V_O = 2.7 V			20			20	μA
				V_O = 0.4 V			−20			−20	
I_I	Input current at maximum input voltage	Inputs 1 thru 7	V_{CC} = MAX,	V_I = 7 V			0.2			0.2	mA
		All other inputs					0.1			0.1	
I_{IH}	High-level input current	Inputs 1 thru 7	V_{CC} = MAX,	V_I = 2.7 V			40			40	μA
		All other inputs					20			20	
I_{IL}	Low-level input current	Inputs 1 thru 7	V_{CC} = MAX,	V_I = 0.4 V			−0.8			−0.8	mA
		All other inputs					−0.4			−0.4	
I_{OS}	Short-circuit output current§	Outputs A0, A1, A2	V_{CC} = MAX		−30		−130	−30		−130	mA
		Outputs EO, GS			−20		−100	−20		−100	
I_{CC}	Supply current		V_{CC} = MAX, See Note 2	Condition 1		13	25		13	25	mA
				Condition 2		12	23		12	23	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time.

NOTE 2: I_{CC} (condition 1) is measured with inputs 7 and EI grounded, other inputs and outputs open. I_{CC} (condition 2) is measured with all inputs and outputs open.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER†	FROM (INPUT)	TO (OUTPUT)	WAVEFORM	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	1 thru 7	A0, A1, or A2	In-phase output	C_L = 45 pF, R_L = 667 Ω, See Note 3		11	17	ns
t_{PHL}						20	30	
t_{PLH}	1 thru 7	A0, A1, or A2	Out-of-phase output			23	35	ns
t_{PHL}						23	35	
t_{PZH}	EI	A0, A1, or A2				25	39	ns
t_{PZL}						24	41	
t_{PLH}	0 thru 7	EO	Out-of-phase output	C_L = 15 pF, R_L = 2 kΩ, See Note 3		11	18	ns
t_{PHL}						26	40	
t_{PLH}	0 thru 7	GS	In-phase output			38	55	ns
t_{PHL}						9	21	
t_{PLH}	EI	GS	In-phase output			11	17	ns
t_{PHL}						14	36	
t_{PLH}	EI	EO	In-phase output			17	26	ns
t_{PHL}						25	40	
t_{PHZ}	EI	A0, A1, or A2		C_L = 5 pF, R_L = 667 Ω		18	27	ns
t_{PLZ}						23	35	

† t_{PLH} = propagation delay time, low-to-high-level output
t_{PHL} = propagation delay time, high-to-low-level output
t_{PZH} = output enable time to high level
t_{PZL} = output enable time to low level
t_{PHZ} = output disable time from high level
t_{PLZ} = output disable time from low level

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

TYPICAL APPLICATION DATA

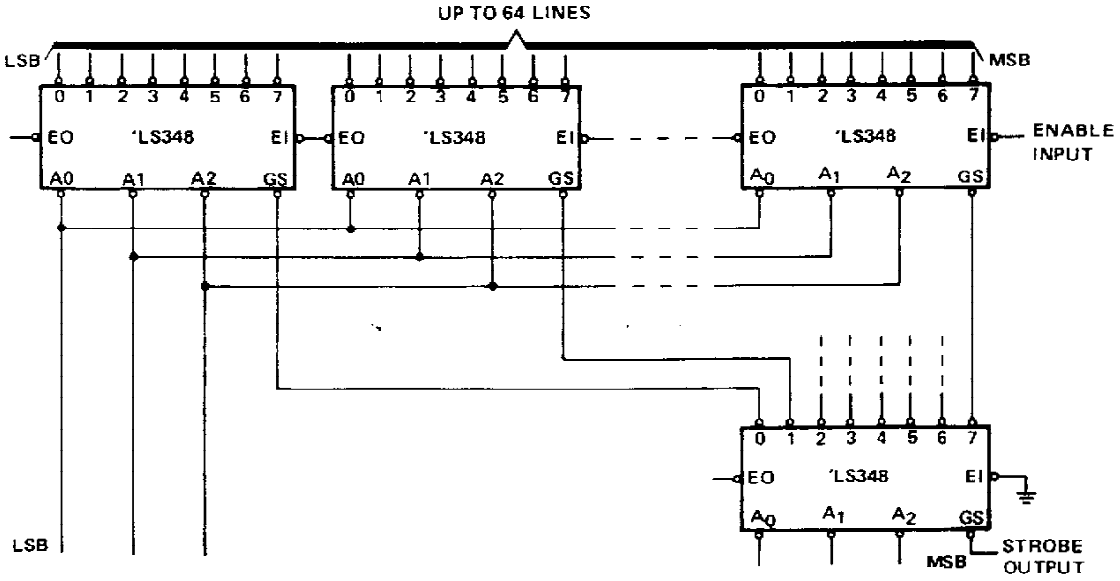


FIGURE 1–PRIORITY ENCODER WITH UP TO 64 INPUTS.

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.